

**Search Notes**

Application/Control No.

10/786,173

Examiner

Christopher R. Lamb

Applicant(s)/Patent under  
Reexamination

BAEK ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted SPE Wayne Young regarding field of search	10/17/2006	CRL
Consulted SPE Wayne Young; SPE Bill Korzuch regarding allowable subject matter	10/27/2006	CRL
EAST Search	10/28/2006	CRL